IAP20 RES'S FOTTIFF 17 JAN 2006 Sheet 1 of 1

Form PTO-1449 (REV. 8-83)	US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 126627			APPLICATION NO. New U.S. National Stage of				
INFORMATION DISCLOSURE STATEMENT							20	D'T'	P04/01/007(394
(Use several sheets if necessary)				APPLICANTS Hidenori MORIYA et al.						
				FILING I	ATE			J		
					7, 2006			<u> </u>	 	
U.S. PATENT DOCUMENTS										
EXAMINER INITIAL		DOCUMENT NUMBER	1	DATE	NAME				CLASS	SUB CLASS
FOREIGN PATENT DOCUMENTS										
		FOREIGN FATENT DOCUMENTS					SUB			
		DOCUMENT NUMBER	1	DATE		COUNTRY			CLASS	CLASS
ннн	1	JP A 02-204662 w/ abstract	08/14/1990		JAPAN					
ннн	2	JP A 09-189281 w/ abstr. & trans.	07/2	22/1997	JAPAN					
ннн	3	JP A 07-042607 w/ abstr. & trans.	02/10/1995		JAPAN					
ннн	4	JP A 09-250435 w/ abstr. & trans.	09/22/1997		JAPAN -					
ннн	5	JP A 2002-097996 w/abstr. & trans.	04/0	05/2002	JAPAN					
ннн	6	JP A 11-125141 w/ abstr. & trans.	05/	11/1999	JAPAN					
HHH	7	JP A 03-233162 w/ abstract	10/1	17/1991	JAPAN					
нин	8	JP A 07-180645 w/ abstr. & trans.	07/18/1995		JAPAN					
ннн	9	JP A 08-232820 w/ abstr. & trans.	09/10/1996		JAPAN				_	
ннн	10	JP A 63-097873 w/ abstract	04/2	28/1988	JAPAN					
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)										
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EXAMINER /Hai Huynh/ (08/24/2006) DATE CONSIDERED										
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in										
conformance and not considered. Include copy of this form with next communication to applicant.										

Date: January 17, 2006

Sheet I of I	Sheet	-	1	of	1
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Form PTO-14 (REV. 1/06)	PTO-1449 US Dept. of Com			ATTY DOCKET NO. 126627			APPLICATION NO. 10/564,894		
(Use several sheets if necessary)				APPLICANTS			<u> </u>		
				Hideno	ri MORIYA et al.				
				FILING DATE January 17, 2006					
U.S. PATENT DOCUMENTS									
Examiner Initials	Cite No.	Document Number	umber Da		Name .				
ннн	1	5,778,857 A1	7/14/199	8	NAKAMURA et al				
ннн	2	5,738,074 A1	4/14/1998		NAKAMURA et al.				
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6.									
FOREIGN PATENT DOCUMENTS									
Examiner Initials	Cite No.	Document Number	Da	ite	Country		With English Abstract	With English Translation	
нин	3	JP A 9-273468	10/21/19	97	Japan		х	х	
ннн	4	JP A 9-273436	10/21/19	97	Japan		х	х	
ннн	5	JP A 9-317522	12/9/199	7	Japan		x	x	
ннн	6	JP A 9-273437	10/21/19	97	Japan		х	х	
ннн	7	EP 8 103 62 A2	- 12/3/19	97	Europe				
OTHER DOCUMENTS									
Examiner Initials	Cite (Including Author, Title, Date, Pertinent Pages, etc.) No.								
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